

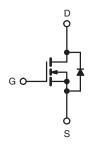
MTP3N55-VB Datasheet **Power MOSFET**

| PRODUCT SUMMARY | | | | | |
|----------------------------|----------------------------|--|--|--|--|
| V _{DS} (V) | 850 | | | | |
| R _{DS(on)} (Ω) | V _{GS} = 10 V 2.7 | | | | |
| Q _g (Max.) (nC) | 78 | | | | |
| Q _{gs} (nC) | 9.6 | | | | |
| Q _{gd} (nC) | 45 | | | | |
| Configuration | Single | | | | |

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T _C | = 25 °C, unl | ess otherwis | se noted) | | | |
|--|--|------------------------|-----------------------------------|------------------|----------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | | V _{DS} | 850 | V | |
| Gate-Source Voltage | | | V _{GS} | ± 20 | v | |
| Continuous Drain Current | V _{GS} at 10 V | T _C = 25 °C | 1 | 4.1 | | |
| | VGS at 10 V | $T_C = 100 \ ^\circ C$ | I _D | 2.6 | А | |
| Pulsed Drain Current ^a | | | I _{DM} | 16 | | |
| Linear Derating Factor | | | | 1.0 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 260 | mJ | |
| Avalanche Current ^a | | | I _{AR} | 4.1 | А | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 13 | mJ | |
| Maximum Power Dissipation | T _C = | 25 °C | P _D | 125 | W | |
| Peak Diode Recovery dV/dt ^c | | | dV/dt | 2.0 | V/ns | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | - 55 to + 150 | - °C | |
| Soldering Recommendations (Peak Temperature) | dering Recommendations (Peak Temperature) for 10 s | | | 300 ^d | | |
| Mounting Torque | 6.00 or 1 | C 00 or M0 oprov | | 10 | lbf ∙ in | |
| Mounting Torque | 6-32 or M3 screw | | | 1.1 | N · m | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 29 mH, $R_g = 25 \Omega$, $I_{AS} = 4.1 \text{ A}$ (see fig. 12). c. $I_{SD} \le 4.1 \text{ A}$, dl/dt $\le 100 \text{ A/}\mu\text{s}$, $V_{DD} \le 600 \text{ V}$, $T_J \le 150 \text{ °C}$. d. 1.6 mm from case.



| THERMAL RESISTANCE RATINGS | | | | | |
|-------------------------------------|-------------------|------|------|------|------|
| PARAMETER | SYMBOL | MIN. | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient | R _{thJA} | - | - | 62 | |
| Case-to-Sink, Flat, Greased Surface | R _{thCS} | - | 0.50 | - | °C/W |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - | - | 1.0 | |

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

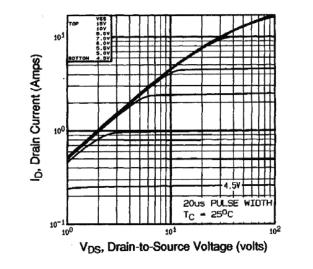
| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|---|---------------------|--|--|------|------|------------------|------|
| Static | | | | | | | • |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = | = 0 V, I _D = 250 μΑ | 850 | - | - | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | Reference | e to 25 °C, I _D = 1 mA | - | 0.90 | - | V/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | V _{DS} = | = V _{GS} , I _D = 250 μΑ | 2.0 | - | 4.0 | V |
| Gate-Source Leakage | I _{GSS} | , | V _{GS} = ± 20 V | - | - | ± 100 | nA |
| | I _{DSS} | V _{DS} = | V _{DS} = 800 V, V _{GS} = 0 V | | - | 100 | |
| Zero Gate Voltage Drain Current | | V _{DS} = 640 V | ∕, V _{GS} = 0 V, T _J = 125 °C | - | - | 500 | μA |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 2.5 A ^b | - | 2.7 | - | Ω |
| Forward Transconductance | 9 _{fs} | V _{DS} = | = 100 V, I _D = 2.5 A | 2.5 | - | - | S |
| Dynamic | | | | | | • | |
| Input Capacitance | C _{iss} | | $V_{GS} = 0 V,$ | - | 1300 | - | |
| Output Capacitance | C _{oss} | | $V_{DS} = 25 V,$ | - | 310 | - | pF |
| Reverse Transfer Capacitance | C _{rss} | f = 1. | .0 MHz, see fig. 5 | - | 190 | - | |
| Total Gate Charge | Qg | | | - | - | 78 | |
| Gate-Source Charge | Q _{gs} | V _{GS} = 10 V | $V_{GS} = 10 \text{ V}$ $I_D = 4.1 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 ^b | | - | 9.6 | nC |
| Gate-Drain Charge | Q _{gd} | | | - | - | 45 | 1 |
| Turn-On Delay Time | t _{d(on)} | | | | 12 | - | - ns |
| Rise Time | t _r | $V_{DD}=400 \text{ V}, \text{ I}_{D}=4.1 \text{ A}, \\ \text{R}_{g}=12 \ \Omega, \text{ R}_{D}=95 \ \Omega, \text{ see fig. } 10^{\text{b}}$ | | - | 33 | - | |
| Turn-Off Delay Time | t _{d(off)} | | | - | 82 | - | |
| Fall Time | t _f | | | - | 30 | - | |
| Internal Drain Inductance | L _D | | Between lead, 6 mm (0.25") from | | 4.5 | - | |
| Internal Source Inductance | L _S | package and center of die contact | | - | 7.5 | - | - nH |
| Drain-Source Body Diode Characteristic | s | | | | | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 4.1 | A |
| Pulsed Diode Forward Current ^a | I _{SM} | | | - | - | 16 | |
| Body Diode Voltage | V_{SD} | $T_J = 25 \ ^{\circ}C, \ I_S = 4.1 \ A, \ V_{GS} = 0 \ V^b$ | | - | - | 1.8 | V |
| Body Diode Reverse Recovery Time | t _{rr} | $T_{\rm J} = 25~{\rm °C}, I_{\rm F} = 4.1~{\rm A}, dI/dt = 100~{\rm A}/\mu{\rm s}^{\rm b}$ | | - | 480 | 720 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | - | 1.8 | 2.7 | nC |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D) | | | | L _D) | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



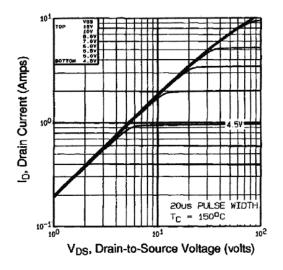


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

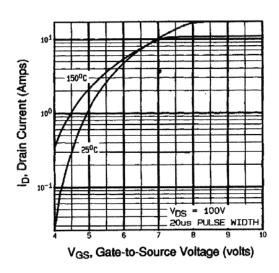


Fig. 3 - Typical Transfer Characteristics

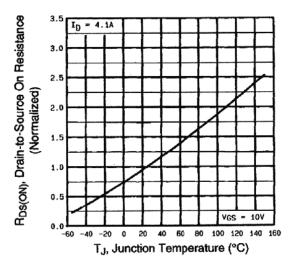


Fig. 4 - Normalized On-Resistance vs. Temperature



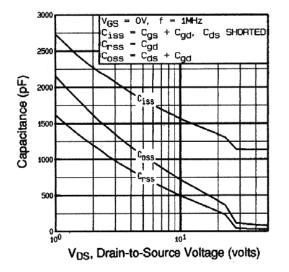


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

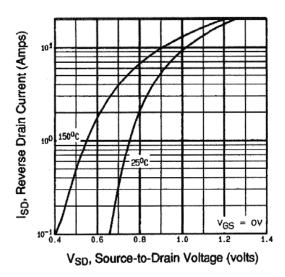


Fig. 7 - Typical Source-Drain Diode Forward Voltage

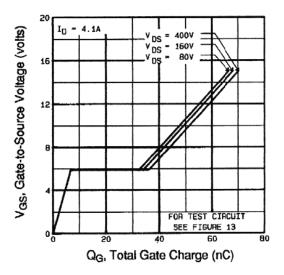


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

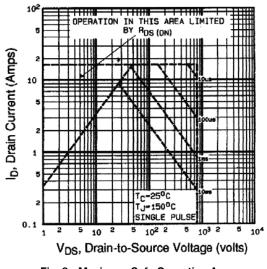


Fig. 8 - Maximum Safe Operating Area



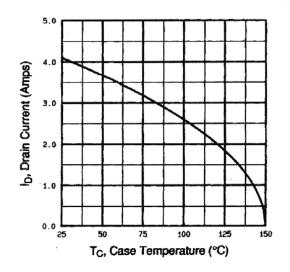


Fig. 9 - Maximum Drain Current vs. Case Temperature

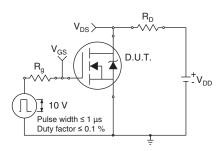


Fig. 10a - Switching Time Test Circuit

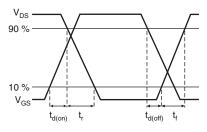
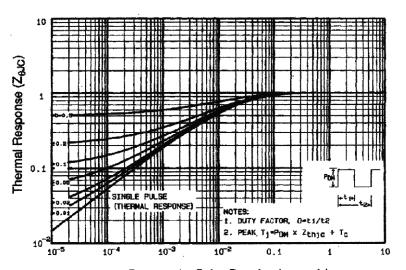


Fig. 10b - Switching Time Waveforms





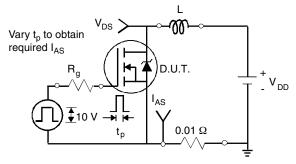


Fig. 12a - Unclamped Inductive Test Circuit

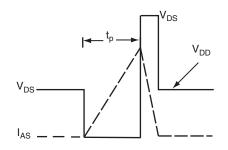


Fig. 12b - Unclamped Inductive Waveforms



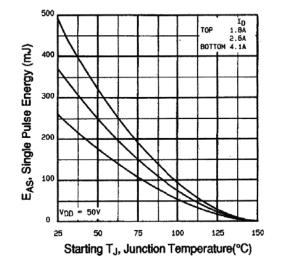


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

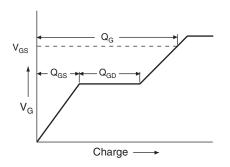


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

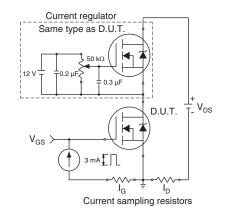
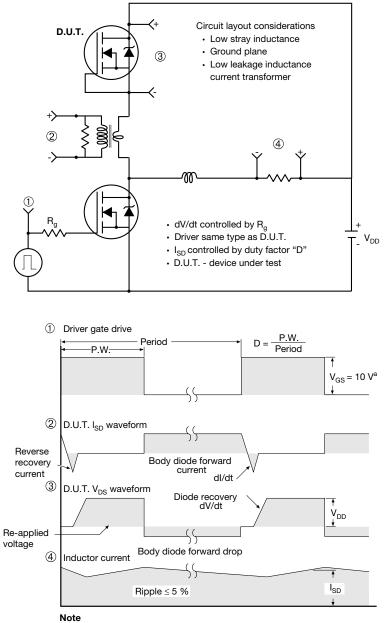


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

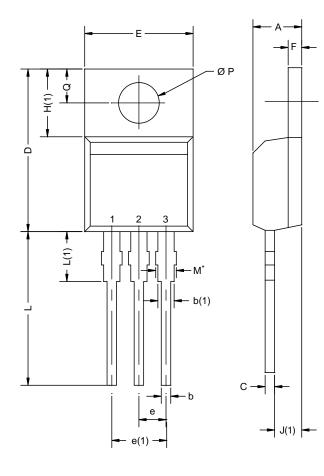


a. $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



TO-220AB



| | MILLIMETERS | | INC | HES | |
|--|-------------|-------|-------|-------|--|
| DIM. | MIN. | MAX. | MIN. | MAX. | |
| А | 4.25 | 4.65 | 0.167 | 0.183 | |
| b | 0.69 | 1.01 | 0.027 | 0.040 | |
| b(1) | 1.20 | 1.73 | 0.047 | 0.068 | |
| С | 0.36 | 0.61 | 0.014 | 0.024 | |
| D | 14.85 | 15.49 | 0.585 | 0.610 | |
| Е | 10.04 | 10.51 | 0.395 | 0.414 | |
| е | 2.41 | 2.67 | 0.095 | 0.105 | |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 | |
| F | 1.14 | 1.40 | 0.045 | 0.055 | |
| H(1) | 6.09 | 6.48 | 0.240 | 0.255 | |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 | |
| L | 13.35 | 14.02 | 0.526 | 0.552 | |
| L(1) | 3.32 | 3.82 | 0.131 | 0.150 | |
| ØΡ | 3.54 | 3.94 | 0.139 | 0.155 | |
| Q | 2.60 | 3.00 | 0.102 | 0.118 | |
| ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471 | | | | | |

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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